



PTO/SB/08a (08-03)

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**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use as many sheets as necessary)

Sheet 1 of 1**Complete if Known**

Application Number	10/717,963
Filing Date	11/21/2003
First Named Inventor	SUMIO ASHIDA
Art Unit	2855 1256
Examiner Name	Unknown <i>Angel</i>
Attorney Docket Number	008312-0306969

U. S. PATENT DOCUMENTS

Examiner Initials ¹	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US-			
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FOREIGN PATENT DOCUMENTS

Examiner Initials ¹	Cite No. ¹	Foreign Patent Document Country Code ³ Number ⁴ Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
<i>u</i>		JP 2003-233931	08/2003	Kojima et al.		

Examiner
Signature*u/h*Date
Considered

4/21/06

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Client Ref.

008312-0306969

T7KO-03S1080

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Applicant: ASHIDA et al.

Appin. No.: 10/717,963

Filing Date: November 21, 2003

Date: April 29, 2005

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Examiner: Unassigned

Group Art Unit: 2655

1756

U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
	BR					
	CR					
	DR					
	ER					
	FR					
	GR					
	HR					
	IR					
	JR					
	KR					
	LR					
	MR					
	NR					

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	Document Number	Date MM/YY YY	Country	Inventor Name	English Abstract	Translation Readily Available
					Enclosed	No
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QR	JP 11-339314 A	12/1999	Japan	NAGINO et al.	x	
RR	JP 03-125343 A	05/1991	Japan	SUZUKI et al.	x	
SR	JP 10-116441 A	05/1998	Japan	ROSEN et al.	x	
TR	JP 2000-339760 A	12/2000	Japan	KUSADA et al.	x	
UR	JP 2001-014723 A	01/2001	Japan	HIROTSUNE et al.	x	
VR	JP 2002-298433 A	10/2002	Japan	YUZUSU et al.	x	
WR					x	
XR						

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YR	Japanese Office Action dated March 29, 2005 for Appin. No. 2002-339437
ZR	Japanese Office Action dated March 29, 2005 for Appin. No. 2002-342896
AAR	
BBR	

Examiner

Date Considered:

4/21/06

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Client Ref.

0306969

T7KO-03S1080

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Applicant: SUMIO ASHIDA et al.

Appln. No.: UNASSIGNED

Filing Date: November 21, 2003

Examiner: UNKNOWN

Group Art Unit: UNKNOWN

Date: November 21, 2003

Page

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U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
	BR					
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	DR					
	ER					
	FR					
	GR					
	HR					
	IR					

	Document Number	Date MM/YYYY	Country	Inventor Name	Enclosed	No	Enclose	No
<i>u</i>	JR 2003-67974	03/2003	Japan	Inao et al.	X			X
<i>u</i>	KR 2000-322770	11/2000	Japan	Osada et al.	X			X
<i>u</i>	LR 2001-232941	08/2001	Japan	Ashida et al.	X			X
<i>u</i>	MR 11-213446	08/1999	Japan	Ota et al.	X			X
<i>u</i>	NR 2000-222777	08/2000	Japan	Uno et al.	X			X
<i>u</i>	OR 2002-279693	09/2002	Japan	Miyamoto et al.	X			X
	PR 2003-233931	08/2003	Japan			X		X
	QR							
	RR							
	SR							

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<i>u</i>	TR	T. Inase et al., "Investigation of Protective Layer for High Transfer Rate Phase Change Optical Disk," Tokyo Research Lab., Tosoh Corp., pages 37-42 (12/2001)			
<i>u</i>	UR	Mayumi Uno et al., "Acceleration of crystallization process by nitride interface layer," Optical Disk Systems Development Center, Matsushita Electric Industrial Co., Ltd., pages 85-90 (11/99)			
<i>u</i>	VR	Rie Kojima et al., "Ge-Sn-Sb-Te Phase-change Recording Material Having High Crystallization Speed," Optical Disk Systems Development Center, Matsushita Electric Industrial Co., Ltd., pages 36-41 (11-12/2000)			
<i>u</i>	WR	Michiaki Shinotsuka et al., "High-speed Blue-laser Recording on the Double-decker Phase Change Disk with High-Reliability," Research and Development Group, Ricoh Company, Ltd., IEEE 2002, pages 234-236 (2002)			
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Examiner

Date Considered: 12/21/06

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 608. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.